

Design, Automation and Test in Europe Conference The European Event for Electronic System Design & Test

Call for Papers

Scope of the Event

The 27th DATE conference is the main European event bringing together designers and design automation users, researchers and vendors as well as specialists in hardware and software design, test and manufacturing of electronic circuits and systems. DATE puts strong emphasis on both technology and systems, covering ICs/SoCs, emerging technologies, embedded systems and embedded software.

Structure of the Event

The multi-day event consists of a conference with keynote talks, regular papers, panels, hot-topic sessions, tutorials, workshops, special focus days and a track for executives. The organisation of user group meetings, fringe meetings, a Young People Programme, vendor presentations and social events offers a wide variety of extra opportunities to meet and exchange information on relevant issues for the design automation, design and test communities. Special space will also be allocated for multi-partner innovative research projects to show their results. More details are available on the DATE website: http://www.date-conference.com.

Areas of Interest

Within the scope of the conference, the main areas of interest are: design automation, design tools and hardware architectures for electronic and embedded systems; test and dependability at system, chip, circuit and device level for analogue and digital electronics; modelling, analysis, design and deployment of embedded software and cyber-physical systems; application design and industrial design experiences. Topics of interest include, but are not restricted to:

- · System Specification and Modelling
- System-level Design Methodologies and High-Level Synthesis
- · System Simulation and Validation
- Design and Test for Analog and Mixed-Signal Circuits and Systems, and MEMS
- · Design and Test of Hardware Security Primitives
- · Design and Test of Secure Systems
- Formal Methods and Verification
- Network-on-Chip and on-chip Communication
- Architectural and Microarchitectural Design
- Low-power, Energy-efficient and Thermal-aware Design
- · Approximate Computing
- Reconfigurable Systems
- Logical and Physical Analysis and Design
- Emerging Design Technologies for Future Computing
- Emerging Design Technologies for Future Memories
- Power-efficient and Sustainable Computing
- Smart Cities, Internet of Everything, Industry 4.0

- Automotive Systems and Smart Energy Systems
- Augmented Living and Personalized Healthcare
- Secure Systems, Circuits and Architectures
- · Self-adaptive and Context-aware Systems
- Applications of Emerging Technologies
- Industrial Experiences
- Modelling and Mitigation of Defects, Faults, Variability and Reliability
- Test Generation, Test Architectures, Design for Test, and Diagnosis
- · Dependability and System-Level Test
- Embedded Software Architectures, Compilers and Tool Chains
- Real-time, Dependable and Privacy-Enhanced Systems
- Machine Learning Solutions for Embedded and Cyber-Physical Systems
- Design Methodologies for Machine Learning Architectures
- Design Modelling and Verification for Embedded and Cyber-Physical Systems

Submission of Papers

All papers must be registered by Sunday, 10 September 2023 AoE (title, abstract and co-authors), the final submission of the paper to be submitted by Sunday, 17 September 2023 AoE (firm deadline) via: http://www.date-conference.com

Chairs

General Chair:

Andy Pimentel, University of Amsterdam, NL
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Programme Chair:

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Conference Organisation

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